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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Michael P. Chudzik, et al.	Date: September 15, 2008
Serial Number: 10/710,947	Examiner: Amy He
Filed: 8/13/2004	Group Art Unit: 2831 Confirmation No. : 4946
Title: Methods for the determination of film continuity and growth modes in thin dielectric films	IBM Corporation D/18G, B/321, Zip 482 2070 Route 52 Hopewell Junction, NY 12533-6531

AMENDMENT UNDER 37C.F.R. § 312 AFTER ALLOWANCE

Commissioner of Patents and Trademarks
P. O. Box 1450
Alexandria, VA 22313-1450

Sir:

Responsive to the Notice of Allowance and Fees due dated June 26, 2008, the following Amendment is being submitted.

Kindly amend the Specification as follows: